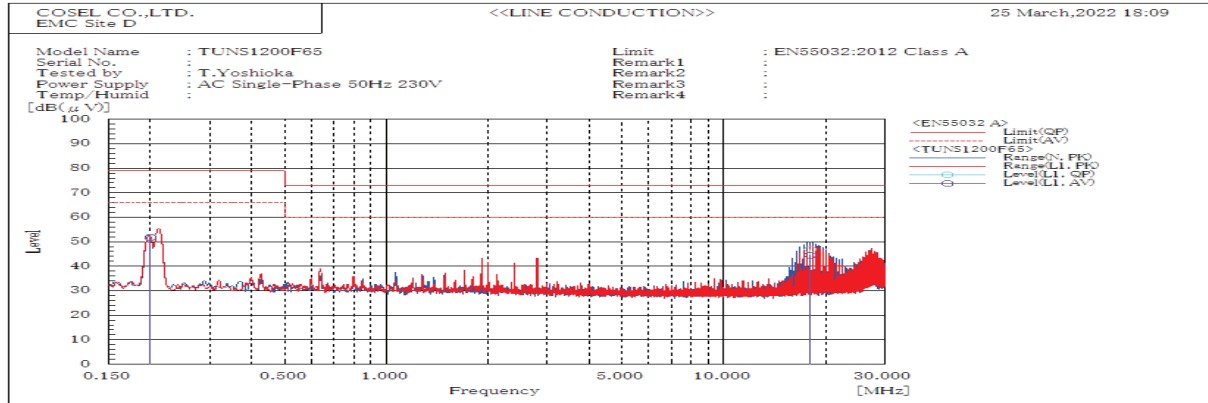
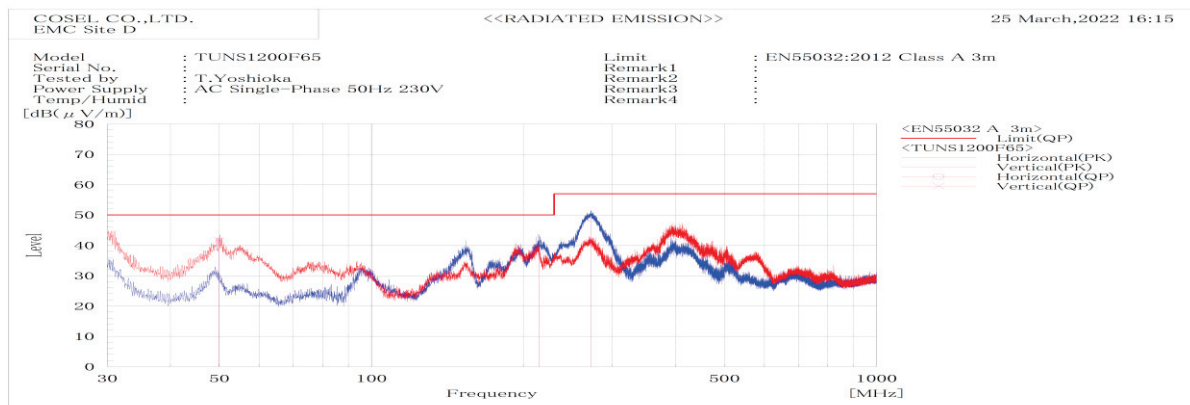


DATA SHEET		Date	10-May-22
Model	TUNS1200F65	Temp.	25 degreeC
Test	EMI Line conduction & Radiated emission	Humid.	40 %RH
		Tested by	T.Yoshioka



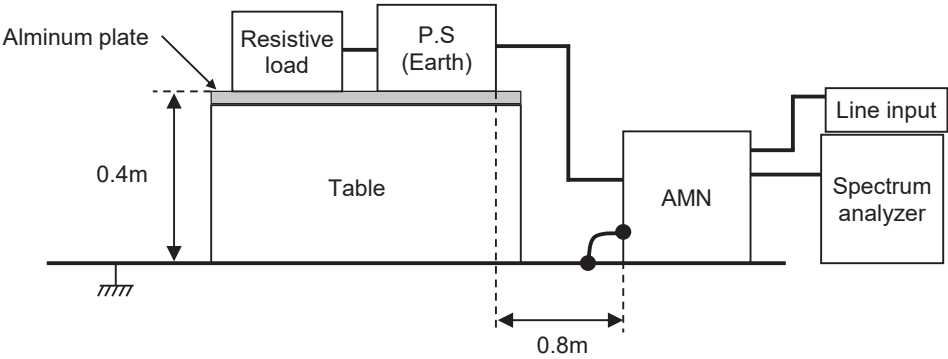
Frequency	Line	Level		Limit		Margin		Pass/Fail	Remark
MHz		dB(μV)		dB(μV)		dB			
		QP	AV	QP	AV	QP	AV		
0.2	L1	52.1	51.7	79	66	26.9	14.3	Pass	
18.011	L1	46.9	44.5	73	60	26.1	15.5	Pass	



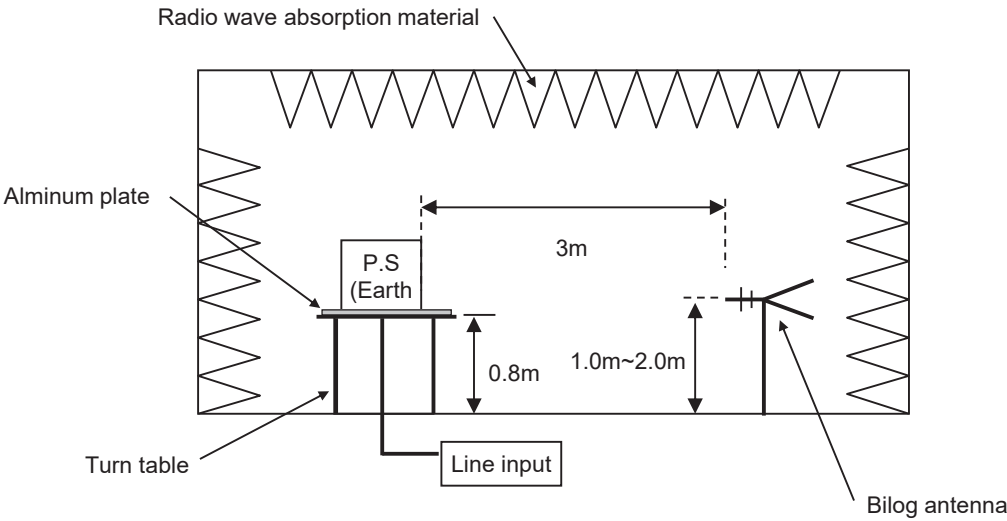
Frequency	Polarization	Stability	Level	Limit	Margin	Pass/Fail	Height	Angle	Remark
MHz			dB(μV/m)	dB(μV/m)	dB		cm	deg	
			QP	QP	QP				
30.004	V	Stable	44	50	6	Pass	100	294.9	
49.856	V	Stable	41.8	50	8.2	Pass	101.5	73	
214.478	H	Stable	38.1	50	11.9	Pass	105.7	338.9	
272.32	H	Stable	49	57	8	Pass	107.7	10.3	

DATA SHEET		Date	10-May-22
Model	Circuit used for measurement	Temp.	25 degreeC
Test	EMI Line conduction & Radiated emission	Humid.	40 %RH
		Tested by	T.Yoshioka

1. Line conduction



2. Radiated emission

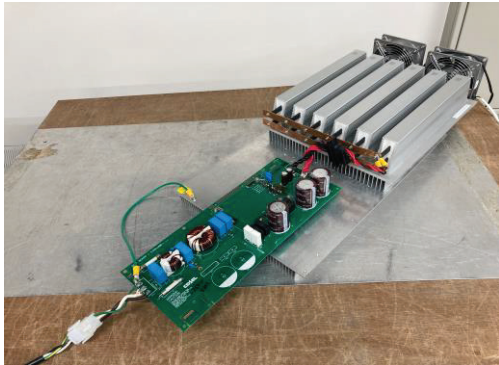


Conditions

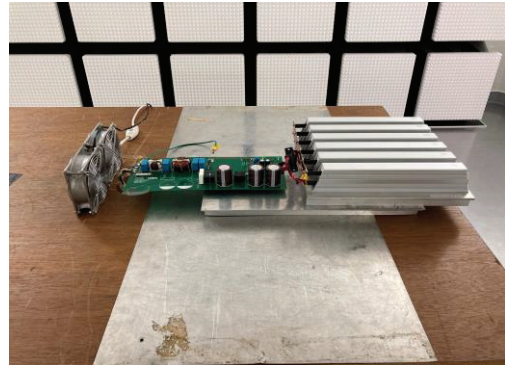
Test : EMI
Model Name: TUNS1200F

○Photographs of Test Set-Up

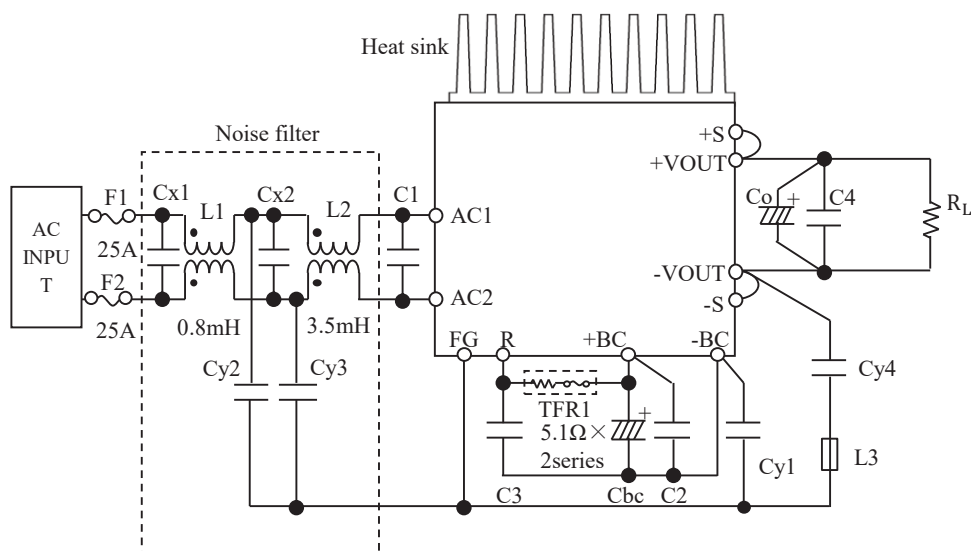
LINE CONDUCTION



RADIATED EMISSION



○Testing circuitry



- L1 : SCR25-200-1R7A008JH
- L2 : SC15-E350H
- L3 : Ferrite Bead (K5B T 4x2x2) × 2series (For TUNS1200F65 only)
- Cx1,Cx2 : 1.5uF 310V Film Capacitor
- Cy1 : 2200pF 400V
- Cy2,Cy3 : 1500pF 400V
- Cy4 : 10000pF 300V (For TUNS1200F65 only)
- C1 : 1.5uF 310V Film Capacitor × 2parallel
- C2,C3 : 1.0uF 630V Film Capacitor × 2parallel
- C4 : 1.0uF Ceramic Capacitor
- Cbc : 470uF 450V Electrolytic Capacitor × 3parallel
- Co : TUNS1200F12 2200uF 25V Electrolytic Capacitor
TUNS1200F28 1000uF 50V Electrolytic Capacitor
TUNS1200F48 470uF 63V Electrolytic Capacitor
TUNS1200F65 150uF 100V Electrolytic Capacitor × 2parallel

Fig.1 Testing circuitry